

SCDS193B-AUGUST 2006-REVISED MARCH 2007

FEATURES

- 2-V to 12-V Single-Supply Operation
- Specified ON-State Resistance:
 - 15 Ω Max With 12-V Supply
 - 20 Ω Max With 5-V Supply
 - 50 Ω Max With 3.3-V Supply
- Specified Low OFF-Leakage Currents:
 - 1 nA at 25°C
 - 10 nA at 85°C

- Specified Low ON-Leakage Currents:
 - 1 nA at 25°C
 - 10 nA at 85°C
- Low Charge Injection: 11.5 pC (12-V Supply)
- Fast Switching Speed:
 - $t_{ON} = 80 \text{ ns}, t_{OFF} = 50 \text{ ns} (12-V \text{ Supply})$
- Break-Before-Make Operation (t_{ON} > t_{OFF})
- TTL/CMOS-Logic Compatible With 5-V Supply

DESCRIPTION/ORDERING INFORMATION

The TS12A4514/TS12A4515 are single pole/single throw (SPST), low-voltage, single-supply CMOS analog switches, with very low switch ON-state resistance. The TS12A4514 is normally open (NO). The TS12A4515 is normally closed (NC).

These CMOS switches can operate continuously with a single supply between 2 V and 12 V. Each switch can handle rail-to-rail analog signals. The OFF-leakage current maximum is only 1 nA at 25°C or 10 nA at 85°C.

All digital inputs have 0.8-V to 2.4-V logic thresholds, ensuring TTL/CMOS-logic compatibility when using a 5-V supply.

For pin-compatible parts for use with dual supplies, see the TS12A4516/TS12A4517.

ORDERING INFORMATION

T _A	PACKAGE ⁽¹⁾		ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP – P	Reel of 1000	TS12A4514P	TS12A4514P
	SOIC - D	Reel of 1500	TS12A4514D	VD514
	201C - D	Reel of 2500	TS12A4514DR	YD514
–40°C to 85°C	SOP (SOT-23) – DBV	Reel of 3000	TS12A4514DBVR	PREVIEW
-40°C 10 85°C	PDIP – P	Reel of 1000	TS12A4515P	TS12A4515P
	SOIC - D	Reel of 1500	TS12A4515D	YD515
	3010 - D	Reel of 2500	TS12A4515DR	טוטעז
	SOP (SOT-23) – DBV	Reel of 3000	TS12A4515DBVR	PREVIEW

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

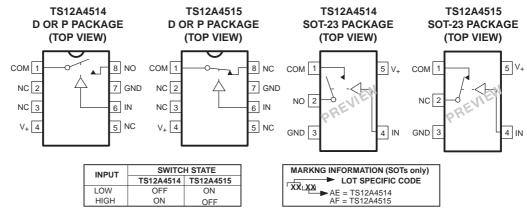


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PIN CONFIGURATIONS



N.C. = Not internally connected NO = Normally open

Absolute Minimum and Maximum Ratings(1)(2)

	lute Minimum and Maximum Rates s referenced to GND	tings ⁽¹⁾⁽²⁾	The state of the s			
			2 B	MIN	MAX	UNIT
V ₊	Supply voltage range ⁽³⁾		26 m	-0.3	13	V
$V_{NC} V_{NO} V_{COM}$	Analog voltage range ⁽⁴⁾		COL	-0.3	V ₊ + 0.3 or ±20 mA	V
	Continuous current into any terminal				±20	mA
	Peak current, NO or COM (pulsed at 1 ms, 10	0% duty cycle)			±30	mA
	ESD per method 3015.7				>2000	V
		8-pin plastic DI	P (derate 9.09 mW/°C above 70°C)		727	
	Continuous power dissipation (T _A = 70°C)	8-pin SOIC (de	rate 5.88 mW/°C above 70°C)		471	mW
		5-pin SOT-23 (derate 7.1 mW/°C above 70°C)		571	
T _A	Operating temperature range			-40	85	°C
T _{stg}	Storage temperature range			-65	150	°C
	Lead temperature (soldering, 10 s)				300	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum

All voltages are with respect to ground, unless otherwise specified. (3)

Voltages exceeding V₊ or GND on any signal terminal are clamped by internal diodes. Limit forward-diode current to maximum current rating.



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Electrical Characteristics for 5-V Supply⁽¹⁾

 $V_{+} = 4.5 \text{ V}$ to 5.5 V, $V_{\text{INH}} = 2.4 \text{ V}$, $V_{\text{INL}} = 0.8 \text{ V}$, $T_{\text{A}} = -40^{\circ}\text{C}$ to 85°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS	T _A	MIN TYP(2)	MAX	UNIT	
Analog Switch			^				
Analog signal range	V _{COM} , V _{NO} , V _{NC}			0	V ₊	V	
		$V_{+} = 4.5 \text{ V}, V_{COM} = 3.5 \text{ V},$	25°C	9.5	15		
ON-state resistance	r _{on}	I _{COM} = 1 mA	Full		20	Ω	
ON-state resistance		V _{COM} = 1 V, 2 V, 3 V,	25°C	1	3	_	
flatness	r _{on(flat)}	I _{COM} = 1 mA	Full		4	Ω	
NO, NC	I _{NO(OFF)} ,	V ₊ = 5.5 V, V _{COM} = 1 V,	25°C		1	nA	
OFF leakage current ⁽³⁾	I _{NC(OFF)}	V_{NO} or $V_{NC} = 4.5 \text{ V}$	Full		10	ΠA	
СОМ	1	V ₊ = 5.5 V, V _{COM} = 1 V,	25°C		1	nA	
OFF leakage current ⁽³⁾	I _{COM(OFF)}	V_{NO} or $V_{NC} = 4.5 \text{ V}$	Full		10	IIA	
СОМ	I	$V_{+} = 5.5 \text{ V}, V_{COM} = 4.5 \text{ V}, V_{NO} \text{ or } V_{NC} = 4.5 \text{ V}$	25°C		1	nA	
ON leakage current ⁽³⁾	I _{COM(ON)}	V_{NO} or $V_{NC} = 4.5 \text{ V}$	Full		10	11/4	
Digital Control Input (IN)							
Input logic high	V_{IH}		Full	2.4	V_{+}	V	
Input logic low	V_{IL}		Full	0	8.0	V	
Input leakage current	I _{IH} , I _{IL}	$V_{IN} = V_+, 0 V$	Full		0.01	μΑ	
Dynamic		20 75	-0.0				
Turn-on time	ton	see Figure 2	25°C	32	100	ns	
		See Figure 2	Full		125	115	
Turn-off time		see Figure 2	25°C	25	50	ns	
rum-on ume	t _{OFF}	See Figure 2	Full		60	115	
Charge injection (4)	Q_{C}	$C_L = 1 \text{ nF}, V_{NO} = 0 \text{ V},$ $R_S = 0 \Omega$, See Figure 1	25°C	-3		рС	
NO, NC OFF capacitance	$C_{NO(OFF)}$, $C_{NC(OFF)}$	f = 1 MHz, See Figure 4	25°C	7.5		pF	
COM OFF capacitance	C _{COM(OFF)}	f = 1 MHz, See Figure 4	25°C	7.5		pF	
COM ON capacitance	C _{COM(ON)}	f = 1 MHz, See Figure 4	25°C	19		pF	
Digital input capacitance	C _I	$V_{IN} = V_+, 0 V$	25°C	1.5		pF	
Bandwidth	BW	$R_L = 50 \Omega, C_L = 15 pF,$ $V_{NO} = 1 V_{RMS}, f = 100 kHz$	25°C	475		MHz	
OFF isolation	O _{ISO}	$R_L = 50 \Omega, C_L = 15 pF,$ $V_{NO} = 1 V_{RMS}, f = 100 kHz$	25°C	-94		dB	
Total harmonic distortion	THD	$R_L = 50 \ \Omega, \ C_L = 15 \ pF,$ $V_{NO} = 1 \ V_{RMS}, \ f = 100 \ kHz$	25°C	0.08		%	
Supply							
V cumply current		$V_{IN} = 0 \text{ V or } V_+$	25°C		0.05	^	
V ₊ supply current	current I ₊	v _{IN} = 0 v 0i v ₊	Full		0.1	μΑ	

⁽¹⁾ The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.

 ⁽²⁾ Typical values are at T_A = 25°C.
 (3) Leakage parameters are 100% tested at maximum-rated hot operating temperature, and are ensured by correlation at 25°C.
 (4) Specified by design, not production tested



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Electrical Characteristics for 12-V Supply⁽¹⁾

 V_{+} = 11.4 V to 12.6 V, V_{INH} = 5 V, V_{INL} = 0.8 V, T_{A} = -40°C to 85°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS	T _A	MIN TYP ⁽²⁾	MAX	UNIT	
Analog Switch			1				
Analog signal range	V_{COM} , V_{NO} , V_{NC}			0	V_{+}	V	
ON state mediates	_	V ₊ = 11.4 V, V _{COM} = 10 V,	25°C	6.5	10	0	
ON-state resistance	r _{on}	I _{COM} = 1 mA	Full		15	Ω	
ON-state resistance		V ₊ = 11.4 V,	25°C	1.5	3		
flatness	r _{on(flat)}	$V_{COM} = 2 \text{ V, } 5 \text{ V, } 10 \text{ V,}$ $I_{COM} = 1 \text{ mA}$	Full		4	Ω	
NO, NC	I _{NO(OFF)} ,	$V_{+} = 12.6 \text{ V}, V_{COM} = 1 \text{ V},$	25°C		1	nA	
OFF leakage current ⁽³⁾	I _{NC(OFF)}	V_{NO} or $V_{NC} = 10 \text{ V}$	Full		10	IIA	
COM	1	$V_{+} = 12.6 \text{ V}, V_{COM} = 1 \text{ V},$	25°C		1	nA	
OFF leakage current ⁽³⁾	I _{COM(OFF)}	V_{NO} or $V_{NC} = 10 \text{ V}$	Full		10	IIA	
COM	1	$V_{+} = 12.6 \text{ V}, V_{COM} = 10 \text{ V}, V_{NO} \text{ or } V_{NC} = 10 \text{ V}$	25°C		1	nA	
ON leakage current ⁽³⁾	I _{COM(ON)}	V_{NO} or $V_{NC} = 10 \text{ V}$	Full		10	IIA	
Digital Control Input (IN)			4				
Input logic high	V_{IH}		Full	5	V_{+}	V	
Input logic low	V _{IL}	21	Full	0	0.8	V	
Input leakage current	I _{IH} , I _{IL}	V _{IN} = V ₊ , 0 V	Full		0.001	μΑ	
Dynamic		1 %	-101-				
T	t _{ON}	054	25°C	22	75		
Turn-on time		See Figure 2	Full		80	ns	
T		12.4	25°C	20	45		
Turn-off time	t _{OFF}	See Figure 2	Full		50	ns	
Charge injection (4)	Q _C	$C_L = 1$ nF, $V_{NO} = 0$ V, $R_S = 0$ Ω , See Figure 1	25°C	-11.5		pC	
NO, NC OFF capacitance	C _{NO(OFF)} C _{NC(OFF)}	f = 1 MHz, See Figure 4	25°C	7.5		pF	
COM OFF capacitance	C _{COM(OFF)}	f = 1 MHz, See Figure 4	25°C	7.5		pF	
COM ON capacitance	C _{COM(ON)}	f = 1 MHz, See Figure 4	25°C	21.5		pF	
Digital input capacitance	C _I	$V_{IN} = V_+, 0 V$	25°C	1.5		pF	
Bandwidth	BW	$R_L = 50 \Omega, C_L = 15 pF,$ $V_{NO} = 1 V_{RMS}, f = 100 kHz$	25°C	520		MHz	
OFF isolation	O _{ISO}	$R_L = 50 \Omega, C_L = 15 pF,$ $V_{NO} = 1 V_{RMS}, f = 100 kHz$	25°C	-95		dB	
Total harmonic distortion	THD	$R_L = 50 \ \Omega, \ C_L = 15 \ pF, \ V_{NO} = 1 \ V_{RMS}, \ f = 100 \ kHz$	25°C	0.07		%	
Supply			,		'		
V supply supply	1	\\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	25°C	0.0		^	
V ₊ supply current	I ₊	$V_{IN} = 0 V \text{ or } V_+$	Full		0.2	μA	

The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.
 Typical values are at T_A = 25°C.
 Leakage parameters are 100% tested at maximum-rated hot operating temperature, and are ensured by correlation at 25°C.
 Specified by design, not production tested



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Electrical Characteristics for 3-V Supply (1)

 $V_{+} = 3 \text{ V to } 3.6 \text{ V}, T_{A} = -40^{\circ}\text{C} \text{ to } 85^{\circ}\text{C} \text{ (unless otherwise noted)}$

PARAMETER	SYMBOL	TEST CONDITIONS	T _A	MIN TYP(2)	MAX	UNIT	
Analog Switch			1				
Analog signal range	V_{COM}, V_{NO}, V_{NC}			0	٧,	V	
ON state assistance		$V_{+} = 3 \text{ V}, V_{COM} = 1.5 \text{ V},$	25°C	18.5	40		
ON-state resistance	r _{on}	$I_{NO} = 1 \text{ mA},$	Full		50	Ω	
ON-state resistance		V ₊ = 3 V,	25°C	1	3		
flatness	r _{on(flat)}	$V_{COM} = 1 \text{ V}, 1.5 \text{ V}, 2 \text{ V}, I_{COM} = 1 \text{ mA}$	Full		4	Ω	
NO, NC	I _{NO(OFF)} ,	$V_{+} = 3.6 \text{ V}, V_{COM} = 1 \text{ V}, V_{NO} \text{ or } V_{NC} = 3 \text{ V}$	25°C		1	nA	
OFF leakage current ⁽³⁾	I _{NC(OFF)}	V_{NO} or $V_{NC} = 3 \text{ V}$	Full		10	ПА	
СОМ	I	$V_{+} = 3.6 \text{ V}, V_{COM} = 1 \text{ V},$	25°C		1	nA	
OFF leakage current ⁽³⁾	I _{COM(OFF)}	V_{NO} or $V_{NC} = 3 \text{ V}$	Full		10	ПА	
СОМ	I	$V_{+} = 3.6 \text{ V}, V_{COM} = 3 \text{ V}, V_{NO} \text{ or } V_{NC} = 3 \text{ V}$	25°C		1	nA	
ON leakage current ⁽³⁾	I _{COM(ON)}	V_{NO} or $V_{NC} = 3 \text{ V}$	Full		10	ПА	
Digital Control Input (IN)			-0				
Input logic high	V_{IH}		Full	2.4	V_{+}	V	
Input logic low	V_{IL}	21	Full	0	8.0	V	
Input leakage current	I _{IH} , I _{IL}	$V_{IN} = V_+, 0 V$	Full		0.01	μΑ	
Dynamic		180	M.				
Turn-on time (4)	t _{ON}	See Figure 2	25°C	63	120	ns	
rum-on ume		See Figure 2	Full		175	115	
Turn-off time ⁽⁴⁾		San Figure 2	25°C	33	80		
rum-on ume	t _{OFF}	See Figure 2	Full		120	ns	
Charge injection ⁽⁴⁾	$Q_{\mathbb{C}}$	C _L = 1 nF, See Figure 1	25°C	-1.5		рС	
NO, NC OFF capacitance	$C_{NO(OFF)}, \ C_{NC(OFF)}$	f = 1 MHz, See Figure 4	25°C	7.5		pF	
COM OFF capacitance	C _{COM(OFF)}	f = 1 MHz, See Figure 4	25°C	7.5		pF	
COM ON capacitance	C _{COM(ON)}	f = 1 MHz, See Figure 4	25°C	17		pF	
Digital input capacitance	Cı	$V_{IN} = V_+, 0 V$	25°C	1.5		pF	
Bandwidth	BW	$R_L = 50 \Omega, C_L = 15 pF,$ $V_{NO} = 1 V_{RMS}, f = 100 kHz$	25°C	460		MHz	
OFF isolation	O _{ISO}	$R_L = 50 \Omega, C_L = 15 pF,$ $V_{NO} = 1 V_{RMS}, f = 100 kHz$	25°C	-94		dB	
Total harmonic distortion	THD	$R_L = 50 \ \Omega, \ C_L = 15 \ pF, \ V_{NO} = 1 \ V_{RMS}, \ f = 100 \ kHz$	25°C	0.15		%	
Supply							
V supply current		$V_{IN} = 0 \text{ V or } V_{+}$	25°C		0.03		
V ₊ supply current	I ₊	v _{IN} = 0 v 0i v ₊	Full		0.05	μA	

The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.
 Typical values are at T_A = 25°C.
 Leakage parameters are 100% tested at maximum-rated hot operating temperature, and are ensured by correlation at 25°C.
 Specified by design, not production tested

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PIN DESCRIPTION(1)

	PIN	I NO.			
TS12	A4514	TS12	2A4515	NAME	DESCRIPTION
D, P	SOT-23	D, P	SOT-23		
1	1	1	1	COM	Common
2, 3, 5	_	2, 3, 5	_	NC	No connect (not internally connected)
4	5	4	5	V ₊	Power supply
6	4	6	4	IN	Digital control to connect COM to NO or NC
7	3	7	3	GND	Digital ground
8	2	_	_	NO	Normally open
_	_	8	2	NC	Normally closed

⁽¹⁾ NO, NC, and COM pins are identical and interchangeable. Any may be considered as an input or an output; signals pass in both directions.



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APPLICATION INFORMATION

Power-Supply Considerations

The TS12A4514/TS12A4515 construction is typical of most CMOS analog switches, except that they have only two supply pins: V_+ and GND. V_+ and GND drive the internal CMOS switches and set their analog voltage limits. Reverse ESD-protection diodes are internally connected between each analog-signal pin and both V_+ and GND. One of these diodes conducts if any analog signal exceeds V_+ or GND.

Virtually all the analog leakage current comes from the ESD diodes to V_+ or GND. Although the ESD diodes on a given signal pin are identical and, therefore, fairly well balanced, they are reverse biased differently. Each is biased by either V_+ or GND and the analog signal. This means their leakages will vary as the signal varies. The difference in the two diode leakages to the V_+ and GND pins constitutes the analog-signal-path leakage current. All analog leakage current flows between each pin and one of the supply terminals, not to the other switch terminal. This is why both sides of a given switch can show leakage currents of the same or opposite polarity.

There is no connection between the analog-signal paths and V_{+} or GND.

 V_{+} and GND also power the internal logic and logic-level translators. The logic-level translators convert the logic levels to switched V_{+} and GND signals to drive the analog signal gates.

Logic-Level Thresholds

The logic-level thresholds are CMOS/TTL compatible when V_+ is 5 V. As V_+ is raised, the level threshold increases slightly. When V_+ reaches 12 V, the level threshold is about 3 V – above the TTL-specified high-level minimum of 2.8 V, but still compatible with CMOS outputs.

CAUTION:

Do not connect the TS12A4514/MAS4515 V_{+} to 3 V and then connect the logic-level pins to logic-level signals that operate from 5-V supply. Output levels can exceed 3 V and violate the absolute maximum ratings, damaging the part and/or external circuits.

High-Frequency Performance

In $50-\Omega$ systems, signal response is reasonably flat up to 250 MHz (see *Typical Operating Characteristics*). Above 20 MHz, the on response has several minor peaks that are highly layout dependent. The problem is not in turning the switch on; it is turning it off. The OFF-state switch acts like a capacitor and passes higher frequencies with less attenuation. At 10 MHz, OFF isolation is about -45 dB in $50-\Omega$ systems, decreasing (approximately 20 dB per decade) as frequency increases. Higher circuit impedances also make OFF isolation decrease. OFF isolation is about 3 dB above that of a bare IC socket, and is due entirely to capacitive coupling.

Test Circuits/Timing Diagrams

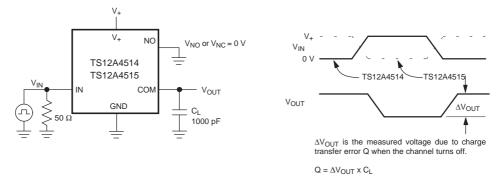


Figure 1. Charge Injection



APPLICATION INFORMATION (continued)

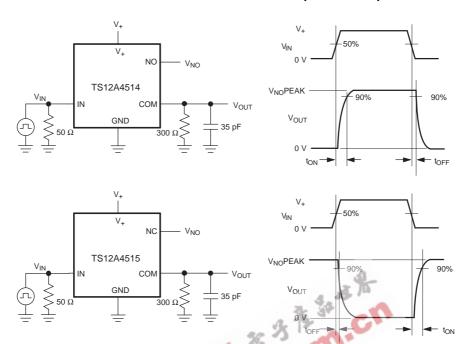


Figure 2. Switching Times

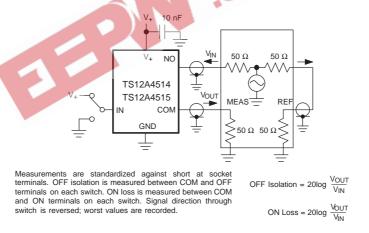


Figure 3. OFF Isolation and ON Loss

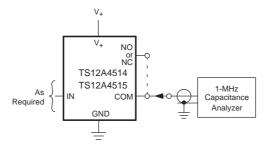


Figure 4. NO, NC, and COM Capacitance



PACKAGE OPTION ADDENDUM

5-Feb-2007

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp (3)
TS12A4514D	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS12A4514DG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS12A4514DR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS12A4514DRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS12A4514P	ACTIVE	PDIP	Р	8	50	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
TS12A4514PE4	ACTIVE	PDIP	Р	8	50	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
TS12A4515D	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS12A4515DG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS12A4515DR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS12A4515DRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS12A4515P	ACTIVE	PDIP	Р	8	50	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
TS12A4515PE4	ACTIVE	PDIP	Р	8	50	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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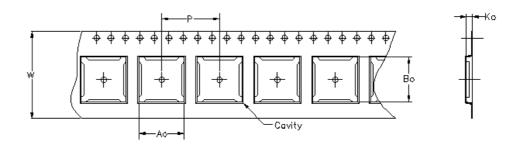
PACKAGE OPTION ADDENDUM

5-Feb-2007

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

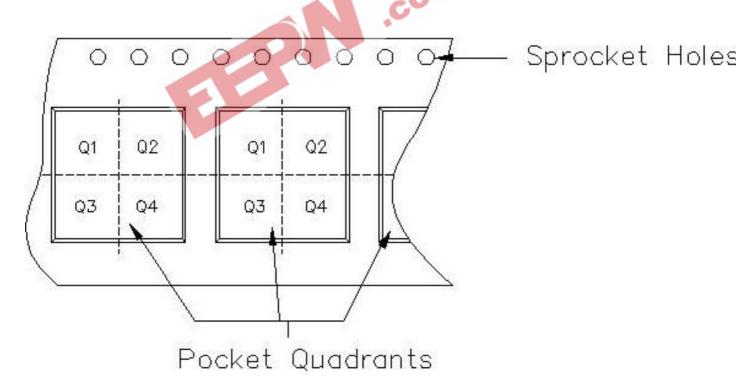






Carrier tape design is defined largely by the component lentgh, width, and thickness

Ao = Dimension designed to accommodate the component width.								
Bo = Dimension designed to accommodate the component length.								
Ko = Dimension designed to accommodate the component thickness.								
W = Overall width of the carrier tape. 🐉 🚕								
P = Pitch between successive cavity centers.								



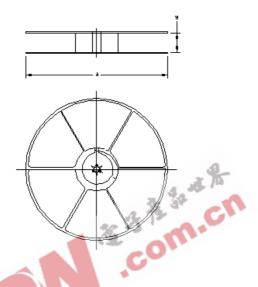
TAPE AND REEL INFORMATION



PACKAGE MATERIALS INFORMATION

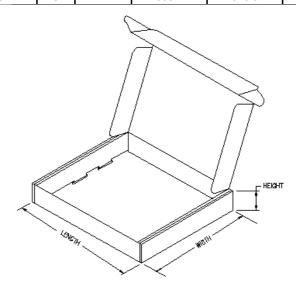
27-Apr-2007

Device	Package	Pins	Site	Reel Diameter (mm)	Reel Width (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS12A4514DR	D	8	MLA	330	12	6.4	5.2	2.1	8	12	Q1
TS12A4515DR	D	8	MLA	330	12	6.4	5.2	2.1	8	12	Q1



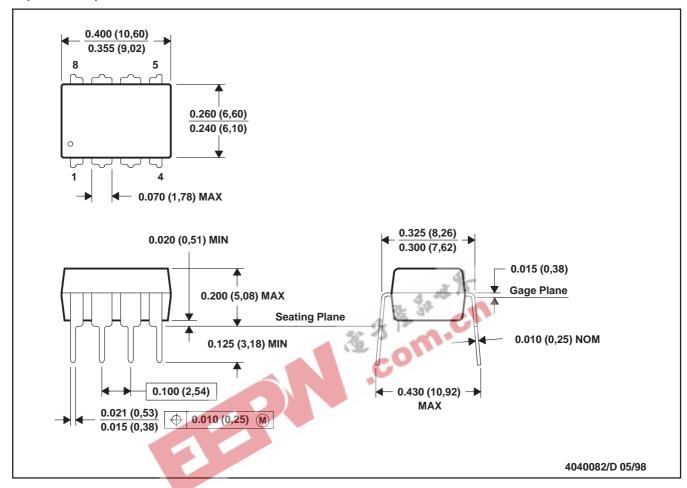
TAPE AND REEL BOX INFORMATION

Device	Package	Pins	Site	Length (mm)	Width (mm)	Height (mm)
TS12A4514DR	D	8	MLA	338.1	340.5	20.64
TS12A4515DR	D	8	MLA	338.1	340.5	20.64



P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

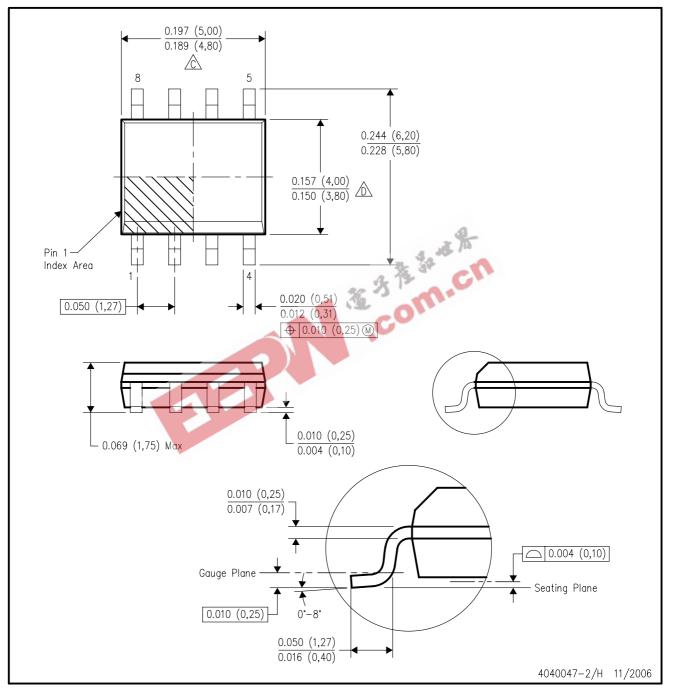
C. Falls within JEDEC MS-001

For the latest package information, go to http://www.ti.com/sc/docs/package/pkg_info.htm



D (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters). B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
- Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
- E. Reference JEDEC MS-012 variation AA.



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